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Pages 1 to 32

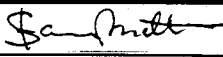

SOLID WIRES, ELECTRICAL

350V, FOR WIRE WRAPPING

ESA/SCC Generic Specification No. 3903



**space components
coordination group**

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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
		<p>This Issue supersedes Issue 1 and incorporates all modifications defined in Revisions 'A', 'B', 'C' and 'D' to Issue 1 and the changes agreed in the following DCRs:-</p> <p>Cover page DCN Para. 8.2.1 : New second sentence added to last paragraph Para. 10.1.2.1 : Item (b), "PDA figure and" deleted from text : Item (c) rewritten</p>		<p>None None 21111 21119 21119</p>



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**1. INTRODUCTION****1.1 SCOPE**

This specification defines the general requirements for the qualification approval, procurement, including lot acceptance testing, and delivery of solid Wires, Electrical, 350Vrms, low frequency, for wire wrapping and space application.

This specification contains the appropriate inspection and test schedules and also specifies the data documentation requirements.

1.2 APPLICABILITY

This specification is primarily applicable to the granting of qualification approval to a component in accordance with ESA/SCC Basic Specification No. 20100 and the procurement of such components from qualified Manufacturers.

2. APPLICABLE DOCUMENTS

The following documents form part of, and shall be read in conjunction with, this specification. The relevant issues shall be those in effect on the date of placing the purchase order.

2.1 ESA/SCC SPECIFICATIONS

No. 20100, Requirements for the Qualification of Standard Electronic Components for Space Application.

No. 20500, External Visual Inspection.

No. 20600, Preservation, Packaging and Despatch of SCC Electronic Components.

No. 21300, Terms, Definitions, Abbreviations, Symbols and Units.

No. 21700, General Requirements for the Marking of SCC Components.

No. 22800, ESA/SCC Non-conformance Control System.

No. 24600, Minimum Quality System Requirements.

With the exception of ESA/SCC Basic Specifications Nos. 20100, 21700, 22800 and 24600, where Manufacturers' specifications are equivalent to, or more stringent than, the ESA/SCC Basic Specifications listed above, they may be used in place of the latter, subject to the approval of the appropriate Qualifying Space Agency.

Such replacements shall be clearly identified in the applicable Process Identification Document (P.I.D.) and listed in an appendix to the appropriate Detail Specification.

Unless otherwise stated herein, references within the text of this specification to "the Detail Specification" shall mean the relevant ESA/SCC Detail Specification.



2.2 OTHER (REFERENCE) DOCUMENTS

MIL-P-26536, Propellant, Hydrazine.

MIL-P-26539, Propellant, Nitrogen Tetroxide.

MIL-W-81822, General Specification for Wire, Electrical, Solderless Wrap Insulated and Uninsulated.

IEC Publication No. 68-2, Basic Environmental Testing Procedures.

FED-STD-228, Cables and Wires, Insulated, Methods of Sampling and Testing.

ASTM B 298-74, Silver-coated Soft or Annealed Copper Wire.

ESA PSS-01-702, A Thermal Vacuum Test for the Screening of Space Materials.

ESA PSS-01-720, Determination of the Susceptibility of Silver-plated Copper Wire/Cable to "Red Plague" Corrosion.

ESA PSS-01-721, Flammability Testing for the Screening of Space Materials.

ESA PSS-01-729, The Determination of Offgassing Products from Materials and Assembled Articles to be used in Manned Space Vehicle Crew Compartment.

ESA PSS-01-730, The Wire Wrapping of High Reliability Electrical Connections.

2.3 ORDER OF PRECEDENCE

For the purpose of interpretation and in case of conflict with regard to documentation, the following order of precedence shall apply:-

- (a) ESA/SCC Detail Specification.
- (b) ESA/SCC Generic Specification.
- (c) ESA/SCC Basic Specification.
- (d) Other documents, if referenced herein.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

The terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. Furthermore, the following terms and definitions shall apply:

- "Finished Wire": A single insulated conductor.
- "Assembly": Any construction other than that of a finished wire(s) without shielding, with or without an outer jacket.
- "Core": Any finished wire in an assembly.

N.B.

In this specification, the term "component" is used instead of "finished wire" and/or "assembly".

- The production lot of a solid silver-plated conductor shall consist of the total length of 1 size being finally available in one continuous length, or in various pieces, which has been drawn to its final dimensions in one continuous process.
- The production lot of finished wire shall consist of the total length of wire being finally available either in one continuous length, or in separate pieces, which has been produced successively:
 - In one continuous processes for the solid conductor.
 - In one continuous process for application of the insulation.

Wire lengths, which have been separated for practical reasons or, for instance because of partial failure of the insulation during the Impulse Dielectric Test, shall be considered to belong to the same production lot.



- The production lot of finished assemblies shall consist of the total length which has been produced successively:
 - In one continuous process for twisting of wires.
 - In one continuous process for the application of the jacket.

Assembly lengths, which have been separated for practical reasons or because of partial failure of the jacket during the Spark Test, shall be considered to belong to the same production lot.

- The term "continuous process" as used above is defined as a manufacturing operation which may have been discontinued for standard or routine interruptions only, but not for disruptions which require resetting of machines or process parameters.

4. REQUIREMENTS

4.1 GENERAL

The test requirements for qualification approval of a component shall comprise final production tests (see Chart II) and qualification testing (see Chart IV).

The test requirements for procurement of components shall comprise final production tests (Chart II) together with, when applicable, a level of lot acceptance testing (see Chart V) to be specified by the Orderer.

If a Manufacturer elects to eliminate a final production test by substituting an in-process control or statistical process control procedure, the Manufacturer is still responsible for delivering components that meet all of the performance, quality and reliability requirements defined in this specification and the Detail Specification.

4.1.1 Specifications

For qualification approval, procurement (including lot acceptance testing) and delivery of components in conformity with this specification, the specifications listed in Section 2 of this document shall apply in total unless otherwise specified herein or in the Detail Specification.

4.1.2 Conditions and Methods of Test

The conditions and methods of test shall be in accordance with this specification, the ESA/SCC Basic Specifications referenced herein and the Detail Specification.

4.1.3 Manufacturer's Responsibility for Performance of Tests and Inspections

The Manufacturer shall be responsible for the performance of tests and inspections required by the applicable specifications. These tests and inspections shall be performed at the plant of the Manufacturer of the components unless it is agreed by the Qualifying Space Agency prior to commencing qualification testing, or procurement, to use an approved external facility.

4.1.4 Inspection Rights

The Qualifying Space Agency (for qualification approval or for a procurement) reserves the right to monitor any of the tests and inspections scheduled in the applicable specifications.

4.1.5 Pre-encapsulation Inspection

Not applicable.

4.2 QUALIFICATION APPROVAL REQUIREMENTS ON A MANUFACTURER

To obtain and maintain the qualification approval of a component, or family of components, a Manufacturer shall satisfy the requirements of ESA/SCC Basic Specification No. 20100.



4.3 DELIVERABLE COMPONENTS

Components delivered to this specification shall be processed and inspected in accordance with the relevant Process Identification Document (P.I.D.). Each delivered component shall be traceable to its production lot. Components delivered to this specification shall have completed satisfactorily all tests to the testing level and lot acceptance level specified in the purchase order (see Para. 4.3.2).

ESA/SCC qualified components delivered to this specification shall be produced from lots that are capable of passing all tests, and sequences of tests, that are defined in Charts IV and V. The Manufacturer shall not knowingly supply components that cannot meet this requirement. In the event that, subsequent to delivery and prior to operational use, a component is found to be in a condition such that it could not have passed these tests at the time of manufacture, this shall be grounds for rejection of the delivered lot.

4.3.1 Lot Failure

Lot failure may occur during final production tests (Chart II) qualification testing (Chart IV) or lot acceptance testing (Chart V).

Should such failure occur, the non-conformance procedure shall be initiated in accordance with ESA/SCC Basic Specification No. 22800.

Should such failure occur during procurement, the Manufacturer shall notify the Orderer by telex within 2 working days, giving details of the number and mode of failure and the suspected cause.

In the case where qualification approval has been granted to the component, he shall, at the same time by the same means, inform the Qualifying Space Agency in order that the latter may consider its implications.

No further testing shall be performed on the failed components except on instruction from the Orderer. The Orderer shall inform the Manufacturer and the Qualifying Space Agency within 2 working days of receipt of the telex, by the same means, what action shall be taken.

In the case when lot failure occurs during qualification testing, the Manufacturer shall immediately notify the appropriate Qualifying Space Agency who will define a course of action to be followed. No further testing shall be performed on the failed components.

4.3.2 Testing and Lot Acceptance Levels

This specification defines 1 level of testing severity which is designated by the letter 'B' (see Chart I) and 3 levels of lot acceptance testing (see Chart V).

The lot acceptance levels are designated 1, 2 and 3 and are comprised of tests as follows:-

Level 3 (LA3) - None.

Level 2 (LA2) - Electrical and Environmental Subgroup.

Level 1 (LA1) - Endurance Subgroup

plus Electrical and Environmental Subgroup.

The required testing level and lot acceptance level shall both be specified in a purchase order.



4.4 MARKING

All components procured and delivered to this specification from a source qualified according to ESA/SCC Basic Specification No. 20100 shall be marked in accordance with ESA/SCC Basic Specification No. 21700. Thus, they shall bear the ESA symbol to signify their conformance to the ESA/SCC qualification approval requirements and full compliance with the requirements of this specification and the Detail Specification.

Components procured from sources which are not ESA/SCC qualified, provided that they fully comply with the procurement requirements of this specification and the Detail Specification, may bear the SCC marking **with the exception of the ESA symbol.**

N.B. In this case, i.e. for wires and assemblies, the support (spool) only shall be marked.

4.5 MATERIALS AND FINISHES

All non-metallic materials and finishes, that are not within a hermetically sealed enclosure, of the components specified herein shall meet the outgassing requirements as outlined in ESA PSS-01-702.

All insulation materials of the components specified herein shall meet the flammability requirements outlined in ESA PSS-01-721 and the offgassing requirements outlined in ESA PSS-01-729.

Specific requirements for materials and finishes are specified in the Detail Specification.

5. PRODUCTION CONTROL

5.1 GENERAL

The minimum requirements for production control, which are equally applicable to procurement, are defined in ESA/SCC Basic Specification No. 20100, Para's 5.1 and 5.2.

5.2 PROTECTION OF SOLID SILVER-PLATED CONDUCTOR

5.2.1 Packaging of Individual Solid Conductor

After inspection by Quality Control personnel, individual solid conductors shall be stored and shipped on spools that are packaged in sealed inner transparent and outer black plastic bags in accordance with Section 12, alineas (g) and (h).

5.2.2 Processed Solid Conductor

Solid conductors such as those awaiting insulation covering, shall be kept under a maximum humidity of 70% as briefly as possible.

5.3 SPECIAL IN-PROCESS CONTROLS

The following in-process controls are applicable.

5.3.1 Insulation Flaws (Spark Test)

After application of primary insulation, 100% of the finished wire shall pass the insulation flaw test without breakdown. The applicable voltage and frequency shall be as specified in Para. 9.6.



5.3.2 Microsectioning of Solid Conductor

The silver coating of the solid copper conductor and the conductor diameter shall be evaluated by microsectioning, using the following procedure on one sample of each production lot of solid conductor:

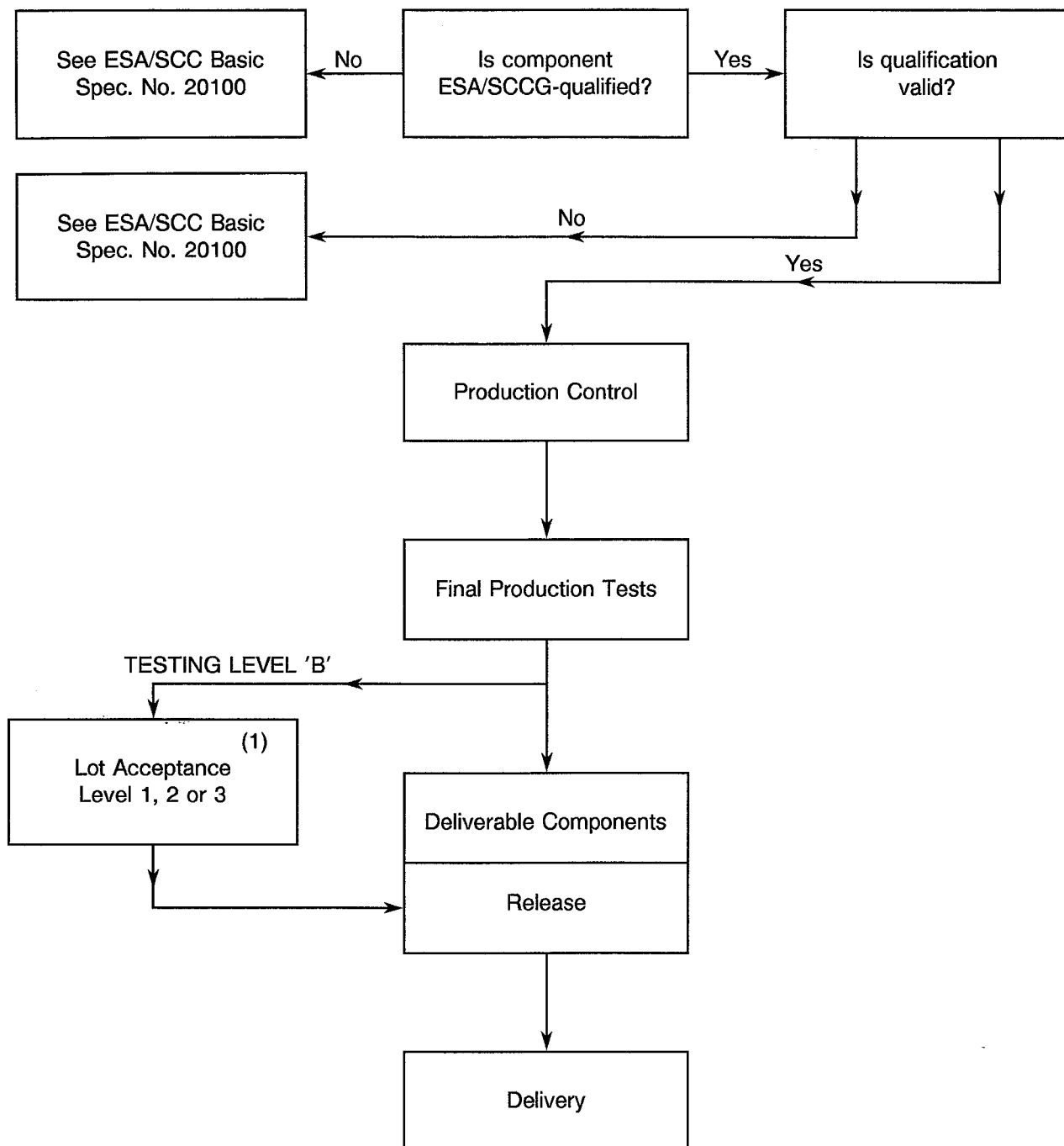
- The samples of solid conductor shall be electroplated with a coating of not less than 25 μ m of copper or nickel to protect the edges during subsequent grinding and polishing.
- The specimens shall be moulded in a low exotherm casting resin.
- The specimen shall be ground and polished transversely to its axis by use of appropriate grinding paper and diamond paste (down to 0.25 μ m diamond paste).
- The polished specimen shall be etched in a fresh solution of ammonia containing a few drops of hydrogen peroxide.
- The etched cross-section shall be examined with a metallographic microscope at a magnification of not less than X400.
- The silver plating shall be uniform and concentric around the copper conductor such that no area around the circumference is covered by less than 2.0 μ m of silver.
- Single points, caused by eccentric copper or minute scratches, that are covered with not less than 1.5 μ m of silver are permitted provided they do not exceed 3 in number around the microsectioned conductor circumference.
- The coating shall be free from porosity, scratches, marks, impurities, corrosion and other defects which disrupt the continuous and complete coating of the copper by silver.
- In case of failure, the total length of solid conductor constituting the production lot shall be rejected.

5.3.3 Documentation

Documentation of special in-process controls shall be in accordance with the requirements of Para. 10.5 of this specification





CHART I - TESTING LEVELS



NOTES

1. When applicable.

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6. FINAL PRODUCTION TESTS

6.1 GENERAL

Unless otherwise specified in the Detail Specification, all components used for qualification testing and all components for delivery, including those submitted to lot acceptance tests, shall be subjected to tests and inspections in accordance with Chart II.

Unless otherwise specified in the Detail Specification, the tests shall be performed in the order shown.

Any components that do not meet these requirements shall be removed from the lot and at no future time be re-submitted to the requirements of this specification.

6.2 TEST METHODS AND CONDITIONS

The applicable test methods and conditions are specified in the paragraphs referenced in Chart II of this specification.

6.3 FAILURE CRITERIA

6.3.1 Parameter Limit Failure

A component shall be counted as a limit failure if 1 or more parameters exceed the limits shown in Table 2 of the Detail Specification.

6.3.2 Other Failures

A component shall be counted as a failure in any of the following cases:

- Mechanical failure.
- Handling failure.
- Lost component.

6.4 FAILED COMPONENTS

A component shall be considered as a failed component if it exhibits 1 or more of the failure modes described in Para. 6.3 of this specification.


6.5 LOT FAILURE

In case of lot failure, the Manufacturer shall act in accordance with the requirements of Para. 4.3.1 of this specification. For the purpose of this specification, 1 failure in any of the following tests and inspections shall constitute a lot failure:

- Para. 9.1 : External Visual Inspection.
- Para. 9.3 : Dimension Check.
- Paras 9.5, 9.7 and 9.8 : Electrical Measurements.
- Para. 9.9 : Stripping Capability.

6.6 DOCUMENTATION

Documentation of final production test data shall be in accordance with the requirements of Para. 10.6 of this specification.

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7. BURN-IN AND ELECTRICAL MEASUREMENTS

Not applicable.

8. QUALIFICATION APPROVAL AND LOT ACCEPTANCE TESTS

8.1 QUALIFICATION TESTING

8.1.1 General

Qualification testing shall be in accordance with the requirements of Chart IV of this specification. The tests to Chart IV shall be performed on the samples specified in the paragraphs of Section 9, chosen at random from a length of cable which has successfully passed the tests in Chart II for Testing Level 'B'. These samples constitute the qualification test lot.

The applicable test requirements are detailed in the paragraphs referenced in Chart IV.

The conditions governing qualification testing are given in ESA/SCC Basic Specification No. 20100, Para 5.3 and, for the extension or renewal of qualification approval, in Paras. 6.3 and 6.4.

8.1.2 Distribution within the Qualification Test Lot

Not applicable.

8.2 LOT ACCEPTANCE TESTING

8.2.1 General

The sample sizes of the 3 lot acceptance levels are specified in Chart V. All components assigned to a subgroup shall be subjected to all of the tests of that subgroup in the sequence shown.

The tests to Chart V shall be performed on the specified sample which shall have been chosen, whenever possible, at random from the proposed delivery lot. The applicable test requirements are detailed in the paragraphs referenced in Chart V.

As a minimum for procurement of non-qualified components, lot acceptance level 3 tests shall apply. For procurement of qualified components, lot acceptance testing shall be performed if specified in a purchase order. Procurement lots ordered with a lot acceptance test level shall be delivered only after successful completion of lot acceptance testing.

8.2.2 Distribution within the Sample for Lot Acceptance Testing

Where a Detail Specification covers a range or series of components that are considered similar, then it may be necessary that the sample for lot acceptance testing be comprised of component types so selected that they adequately represent all of the various mechanical, structural and electrical peculiarities of the procured range or series.


The distribution of the component types will normally vary from procurement to procurement and shall be as specified by the Orderer:-

- (a) In the case of manufacture of variants of the same wire size, the lot acceptance tests shall be performed on the most complex variants and thus all variants will be qualified.
- (b) In the case of manufacture of variants of different wire sizes, the lot acceptance tests shall be performed on each size.

A qualified lot may be divided for delivery purposes.

8.2.3 Lot Acceptance Level 3 Testing (LA3)

No tests or inspections are required for this level.

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8.2.4 Lot Acceptance Level 2 Testing (LA2)

Lot acceptance level 2 testing shall comprise tests on an electrical and environmental subgroup. The following shall apply:-

- (a) The tests in this subgroup are considered to be destructive and therefore components of testing level 'B' so tested shall not form part of the delivery lot.

8.2.5 Lot Acceptance Level 1 Testing (LA1)

Lot acceptance level 1 testing shall comprise the tests for LA2 (electrical and environmental subgroup) plus tests on an endurance subgroup. For the electrical and environmental subgroup, the requirements and conditions for LA2 (see Para 8.2.4) shall apply.

For the endurance subgroup, the following shall apply:-

- (a) The tests in this subgroup are considered to be destructive and therefore components of testing level 'B' so tested shall not form part of the delivery lot.

8.3 FAILURE CRITERIA

The following criteria shall apply to qualification testing and to lot acceptance testing.

8.3.1 Environmental and Mechanical Test Failures

The following shall be counted as component failures:

- Components which fail during tests for which the pass/fail criteria are inherent in the test method, e.g. solderability, resistance to solvents, etc..

8.3.2 Electrical Failures

The following shall be counted as component failures:-

- (a) Components which, when subjected to electrical measurements, in accordance with Table 2 of the Detail Specification, fail one or more of the applicable limits.

8.3.3 Other Failures

The following additional failures may also occur during qualification testing or lot acceptance testing:-



- (a) Components failing to comply with the requirements of ESA/SCC Basic Specification No. 20500.
- (b) Lost components.

8.4 FAILED COMPONENTS

A component shall be considered as failed if it exhibits one or more of the failure modes detailed in Para 8.3 of this specification. The allowable number of failed components per Subgroup, the aggregate failure constraints and the permitted distribution of such failures are shown at the foot of Charts IV and V of this specification.

When requested by the Qualifying Space Agency or the Orderer, failure analysis of failed components shall be performed by the Manufacturer and the results provided.

Failed components from successful lots shall be marked as such and be stored at the Manufacturer's plant for 24 months.

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8.5 LOT FAILURE

A lot shall be considered as failed if the allowable number of failures according to Chart IV or V of this specification, as relevant, has been exceeded.

In the case of lot failure, the Manufacturer shall act in accordance with Para 4.3.1 of this specification.

8.6 DOCUMENTATION

For qualification testing, the qualification test data shall be documented in accordance with the requirements of Para 10.8 of this specification.

In the case of lot acceptance testing, the data shall be documented in accordance with the requirements of Para 10.9 of this specification.



CHART II - FINAL PRODUCTION TESTS

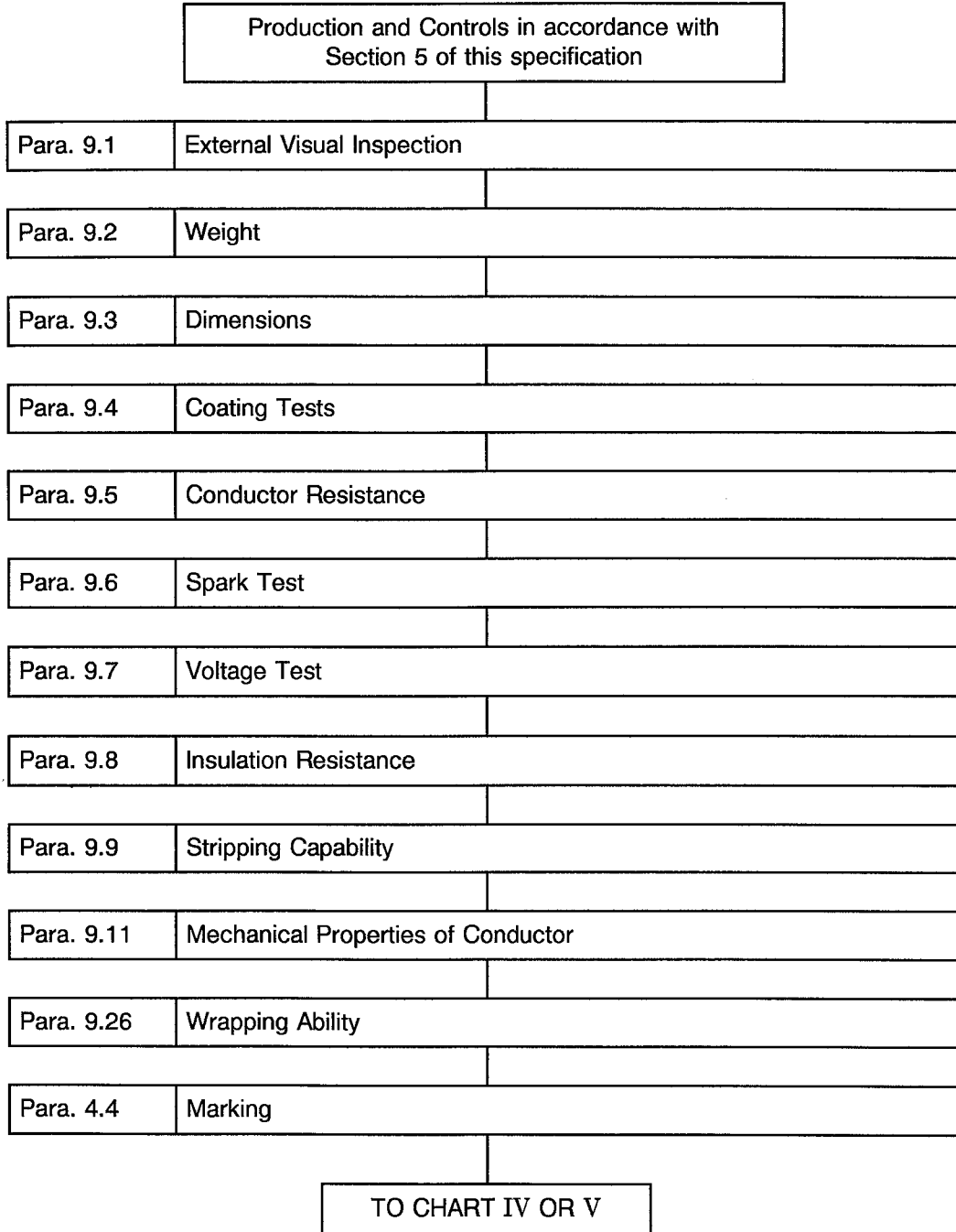
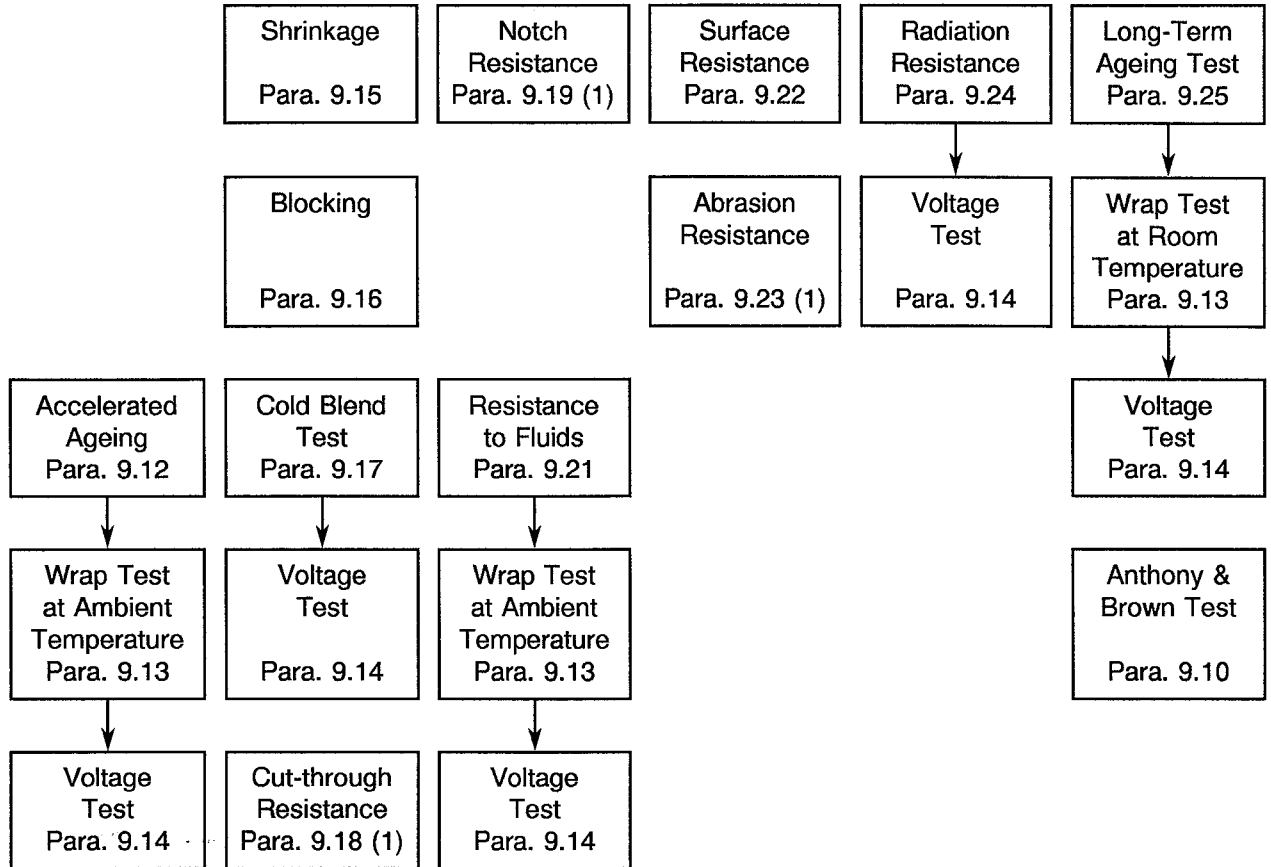


CHART III - BURN-IN AND ELECTRICAL MEASUREMENTS

Not applicable.



CHART IV - QUALIFICATION TESTS



NOTES

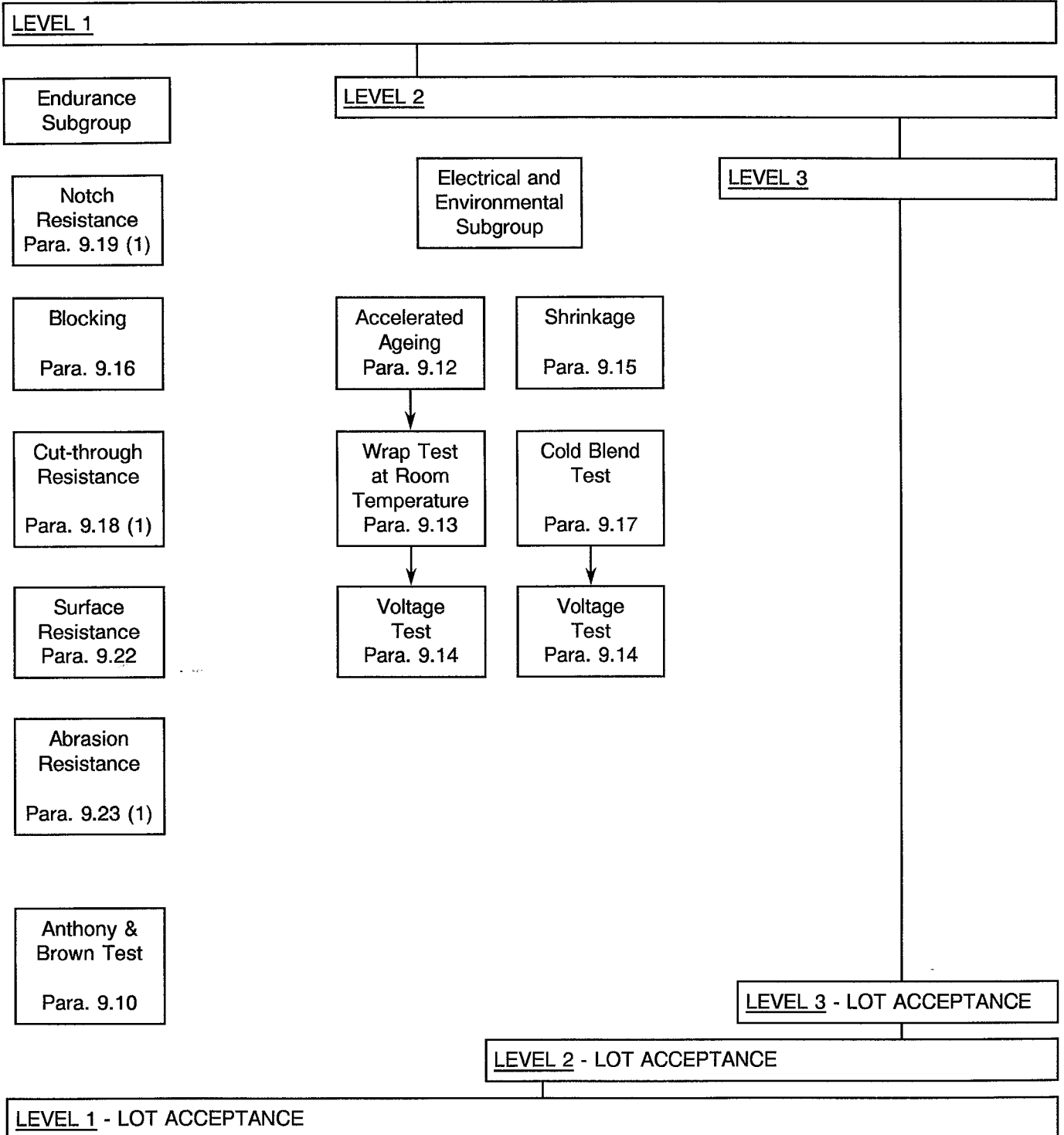
1. Failures are allowed for these tests only.

However, the following restrictions shall be applicable:

- For each test requiring 3 or more samples, only 1 failure is permitted.
- Where applicable, any failed parameter shall be within 30% of the required limit.



CHART V - LOT ACCEPTANCE TESTS





NOTES

1. Failures are allowed for these tests only.

However, the following restrictions shall be applicable:

- For each test requiring 3 or more samples, only 1 failure is permitted.
- Where applicable, any failed parameter shall be within 30% of the required limit.

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9. TEST METHODS AND PROCEDURES

The test methods, conditions and procedures are specified in the following paragraphs.

Whenever sampling is specified at the start and upon completion of lot production, it shall be understood that this means:

- For finished wires, the first and last extruded lengths; for assembly, the first and last assembled lengths.

If a Manufacturer elects to eliminate or modify a test method or procedure, the Manufacturer is still responsible for delivering components that meet all of the performance, quality and reliability requirements defined in this specification and the Detail Specification.

Documentation supporting the change shall be approved by the Qualifying Space Agency and retained by the Manufacturer. It shall be copied, when requested, to the Qualifying Space Agency.

The change shall be specified in the Detail Specification and in the P.I.D.

9.1 EXTERNAL VISUAL INSPECTION

Visual inspection shall be performed on the whole wire length in accordance with the requirements of ESA/SCC Basic Specification No. 20500.

9.2 WEIGHT

The length and weight of a specimen with a minimum length of 3.0 metres shall be measured accurately; the resultant measurements shall be converted into kilograms per 1000 metres. The calculated value shall be in accordance with the requirements of the Detail Specification.

9.3 DIMENSIONS

The dimensions and detail construction of the conductor and primary insulation shall be verified on the basis of the Detail Specification, using 2 samples with a length of 10cm: 1 taken from the start and 1 from the end of the lot production

The finished wire insulation shall be formed concentrically around the conductor. The concentricity shall not be less than 70% when measured in accordance with the Detail Specification.

9.4 COATING TESTS (SOLID CONDUCTOR)



9.4.1 Silver-coated Wires

(a) **Continuity** (ASTM B 298-74)

3 conductors shall be taken, not less than 15cm, from a sample previously straightened by hand. Degrease the specimens for 3 minutes in a solution consisting of alcohol and ether in equal proportions; then wipe them clean with a dry cloth after rinsing in distilled water. Specimens cleaned in this way shall not subsequently be touched by hand.

Immerse the specimens for 30 seconds in a solution of sodium polysulphide of a specific gravity of 1.142 at +20°C; wash them carefully in water. Then immerse the specimens for 15 seconds in hydrochloric acid solution of a specific gravity of 1.088 at +20°C. Wash them carefully in water.

On examination of the specimens with the naked eye, no adherent or clearly visible black spots shall be observed. Any blackening occurring less than 15mm from each end shall, however, not be taken into consideration.

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(b) **Adhesion**

3 conductor specimens with a minimum length of 15cm shall be taken from a sample previously straightened by hand. 1 specimen shall be wound around a mandrel of the same diameter as that of the conductor, so as to form 5 turns of a close helix. The metal coating shall be examined with the naked eye; no detachment shall be observed.

(c) **Silver Thickness (ASTM B 298-74, Appendix, Method A)**

The silver coating on a solid conductor shall be shown, by any convenient method, to be not less than 2.0µm.

9.4.2 Other Coatings

Other coatings, if applicable, shall be prescribed by the Detail Specification.

9.5 CONDUCTOR RESISTANCE

The d.c. resistance of the conductor shall be verified by any suitable equipment giving an accuracy of at least 1%. This measurement shall be performed on:

- (a) A sample of 1.0 metre long.
- (b) The whole length (1).

The result shall be as defined in the Detail Specification.

If the room temperature is not +20°C, the measured value R_{Θ} of the ohmic resistance shall be related to +20°C by application of the following formula:-

$$R_{20} = \frac{R_{\Theta}}{1 + \alpha (\Theta - 20)},$$

Where $\alpha = 0.00393$ for copper or the value specified in the Detail Specification for copper alloy.

N.B.

This measurement is performed for homogeneity purposes. Due to the length inaccuracy, the maximum conductor resistance shall not exceed the specified value by more than 3%.

9.6 SPARK TEST

100% of any length of finished cable shall pass the spark test without breakdown. The test shall be performed using either the dry test or the dry impulse test.

9.6.1 Dry Test

An rms voltage of 3.0kV for the insulation and 1.5kV for the jacket shall be applied. The electrode shall consist of a set of small chains or suitable metal probes forming close contact with practically the entire surface of the cable.

The length of the electrode and the speed of the cable shall be such that the insulation is subjected to the voltage test for not less than 0.02 seconds. The frequency of the applied voltage shall be 50Hz.



9.6.2 Dry Impulse Test

The form of signal shall be negative pulse with a peak value of 5.0kV minimum for the insulation and 2.5kV minimum for the jacket, followed by a damped oscillation.

The rise of the negative pulse of the signal between 0% and 90% of the peak voltage shall not be greater than 75 μ s. The peak value of the first positive overshoot of the signal and each of the damped oscillations which flow from it, shall be less than the initial negative pulse. The time during which each pulse and its damped oscillation, both positive and negative, remain at a voltage equal to 80% or higher than the peak voltage shall be between 20 and 100 μ s. The pulse repetition rate shall be between 200 and 500 pulses per second, inclusive. Apart from the regulation of the peak voltage, conformity with the impulse test parameters shall be defined without a capacitive load applied to the electrode.

Where a capacitive load is concerned, the tolerance within the apparatus shall be such that where there is an increase in the capacitive load between electrode and earth, the peak voltage shall not be reduced by more than 12% from an initial load of 12.5pf/25mm to 25pF/25mm of electrode length.

9.7 VOLTAGE TEST

This test shall be performed with alternating voltage (50Hz) on:-

(a) **A Sample**

A length of at least 5.0 metres of finished wire or assembly shall be tested after immersion for 1 hour in a 5% aqueous solution of sodium chloride or in water containing 0.5% of wetting agent.

The voltage shall be applied for 1 minute:

- For single wires, between water and conductor at 1.5kVrms.
- For assembly at 1.5kVrms:-
 1. Between water and joined conductors.
 2. Between conductors.

(b) **The Whole Length**

For assemblies, between conductors, at 1.5kVrms.

9.8 INSULATION RESISTANCE

This test shall be performed on:-

(a) **A Sample**

A length of at least 5.0 metres of finished wire or assembly which has first been submitted to condition (a) of the voltage test specified in Para. 9.7.

The insulation resistance shall be measured after 1 minute of electrification at a voltage of 500Vdc. The insulation resistance shall not be less than the value specified in the Detail Specification.

(b) **The Whole Length**

For assemblies, between conductors.

The insulation resistance shall be measured under the same conditions as specified in (a) above.

**9.9 STRIPPING CAPABILITY (INSULATION PULL-OFF FORCE)**

The insulation on the conductor shall not be loose (2 samples). It shall be possible to strip the insulation of wires without difficulty when using stripping tools or any means fitted to the particular wire construction defined in the Detail Specification.

For insulated wires, the stripping capability shall be checked by the method described in MIL-W-81222:

The clearance hole shall be larger than the conductor diameter of the test specimen by not more than 0.03mm for wire sizes 30 through 26, 0.5mm for sizes 24 and 22 and 0.08mm for sizes 20 and 18.

The maximum force registered by the gauge during the test shall be considered the insulation pull-off force. The insulation pull-off force shall be within the value specified in the Detail Specification.

9.10 ANTHONY AND BROWN TEST (APPLICABLE TO SILVER-PLATED WIRES ONLY)

This test shall be performed in accordance with ESA PSS-01-720 on a sample as specified therein.

Acceptance Criteria:

- Codes 0 to 3: Accept.
- Codes 4 to 5: Reject.

Failure of this test entails failure of the complete qualification or lot acceptance.

9.11 MECHANICAL PROPERTIES OF CONDUCTOR (FED-STD-228-3211)

The test shall be performed on 2 groups of 3 samples with a length of 30cm: 1 group shall originate from the start, the other from the end of lot production.

The tensile characteristics of the conductor shall be measured by means of a tensile tester with an accuracy which is adequate to measure the elongation and pull strength within 1%. The tensile rate shall be 250mm per minute and the length of the specimen between grips shall be 250 ± 5 mm.

The results shall be in conformity with the values specified in the Detail Specification.

9.12 ACCELERATED AGEING**9.12.1 Finished Wires**

25mm of insulation shall be removed from each end of a sample of finished wire with a length of 50cm. The central portion of this specimen shall then be bent at least halfway around a cylindrical mandrel with a diameter as specified in Table A of the Detail Specification. The ends of the conductor shall each be loaded with the weights specified in Table A.

This specimen so prepared on the mandrel shall be placed in a gravity-convected air oven and remain there for a period of 120 hours at a temperature 30°C above the maximum storage temperature specified in Table 1(b) of the Detail Specification.

On completion of the conditioning period, the specimen shall be released from tension, removed from the mandrel and straightened.

The specimen shall then be subjected to the wrap test (see Para. 9.13) and thereafter to the voltage test (see Para. 9.14).



9.12.2 Assemblies

Assemblies shall be aged in accordance with the procedure defined in Para. 9.12.1 except that, instead of being bent around a mandrel, assemblies shall be aged as free coils.

9.13 WRAP TEST AT ROOM TEMPERATURE

At a temperature of $+22 \pm 3$ °C, 1 end of the specimen shall be secured to the mandrel and the other end to the load weight as specified in Table A (for finished wires) and in Table B (for assemblies) of the Detail Specification.

The mandrel shall be rotated until the length of the specimen is wrapped around the mandrel under the specified tension and with its adjoining coils in contact.

The mandrel shall then be rotated in the reverse direction until the length of the cable which was outside during the first wrapping is next to the mandrel. This procedure shall be repeated until 2 bends in each direction have been formed in the same section of the wire.

Any crack or insulation damage shall be considered as a defect.

9.14 VOLTAGE TEST

This test shall be performed as specified in Para. 9.7 for condition (a).

9.15 SHRINKAGE

A 30cm specimen of the finished wire or core shall be cut such that insulation and conductor are flush at both ends.

The specimen shall then be aged at a temperature 30°C above the maximum storage temperature specified in Table 1(b) of the Detail Specification for 6 hours in a gravity-convected air oven.

On completion of this period, the specimen shall be removed from the oven and allowed to return to room temperature.

Shrinkage of the insulation shall be measured by the amount the conductor protrudes beyond any part of the insulation. The shrinkage shall not exceed 2.0mm at either end.

Any detachment of layers along the insulation or at any end shall be considered a defect.

9.16 BLOCKING

A sample shall be wrapped on a mandrel with a diameter as specified in Table A (for finished wires) and in Table B (for assemblies) of the the Detail Specification. It shall be wrapped until 2 layers have been formed, each consisting of 6 to 8 turns per layer. The ends of the sample shall be made firm to prevent unwrapping during test.

The sample shall be placed in an oven with natural ventilation for a period of 6 hours at the maximum storage temperature specified in Table 1(b) of the Detail Specification.

On completion of this period, the sample shall be removed from the oven and allowed to cool for 1 hour at room temperature. It shall then be possible to unwind the sample from the mandrel without difficulty; the turns shall separate easily from each other without sticking to the insulation.

Any detachment of layers, either along the insulation or at the ends, shall be considered as a failure.

**9.17 COLD BEND TEST**

1 of the ends of a 1.0 metre sample shall be attached to a horizontal mandrel and the other end loaded in accordance with Table C of the Detail Specification. The sample shall be placed in a chamber at a temperature 20°C above the minimum storage temperature specified in Table 1(b) of the Detail Specification and kept at this temperature for 4 hours.

The mandrel shall then be rotated at a regular rate until the sample is fully wrapped on the mandrel; the winding rate shall be approximately 2 rpm.

After winding, the sample shall be removed from the chamber and allowed to warm up to room temperature. It shall then be wiped with a dry cloth and visually examined. The cable insulation shall show no cracks.

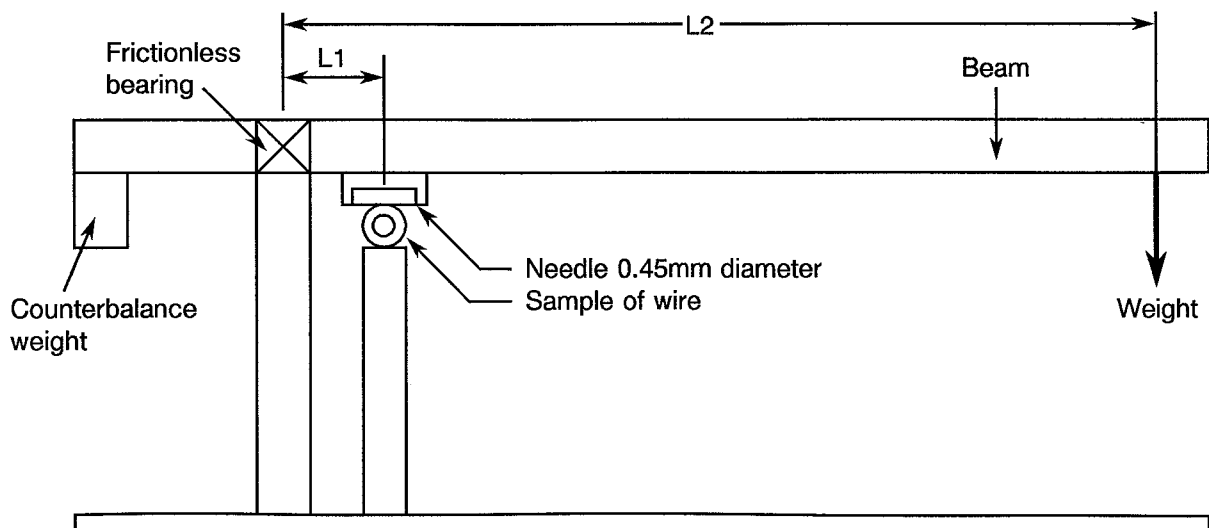
On completion of this test, the sample shall pass the voltage test (see Para. 9.14) satisfactorily.

9.18 CUT-THROUGH RESISTANCE


This test shall be performed to check the behaviour of the finished wire or core when it comes into contact with metal cutting edged. It shall be performed on 3, 30cm long, samples using the equipment described in Figure I of this specification. The beam shall be balanced by adjusting the counterweight such that the arm is motionless and horizontal when no weight is attached to it.

The specimen shall be placed on the mounting of the test equipment, so that the cutting needle is perpendicular to the cable axis. The test shall be carried out at $+22 \pm 3$ °C and the needle used shall have a diameter of 0.45mm (size No. 10).

The end of the beam shall be loaded at a uniform rate of 600 grammes/minute until contact is made between the needle and the conductor. The test shall be performed 3 times on each of the 3 specimens taken from different samples and each specimen shall be moved forward 75mm between tests and turned through an angle of 120°, always in the same direction. The mean load measured during the 9 tests shall not be less than the relevant value specified in the Detail Specification.

FIGURE I - CUT-THROUGH RESISTANCE TEST RIG**NOTES**

1. $L2/L1 = 10$.

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9.19 NOTCH RESISTANCE

This test shall be performed on 3 samples of finished wire or core. Using a razor blade, mounted in a test rig, a notch, perpendicular to the wire axis and to a depth as specified in the Detail Specification, shall be made on each specimen. The notched specimens shall then be wrapped on a mandrel with a diameter equal to 6 times the wire diameter. The notch shall not propagate down to the conductor.

9.20 NOT APPLICABLE.

9.21 RESISTANCE TO FLUIDS

This test shall be performed on 1 60cm long specimen per fluid.

After having been subjected to the immersion test, the specimen shall show no evidence of cracking and shall withstand the voltage test (see Para. 9.14) without breakdown or flash-over. The increase in the specimen's diameter shall not exceed 5%.

Separate specimens of wire with a length of 60cm shall be immersed to within 15cm of their ends in each of the following fluids (a) through (g) for 24 hours at normal room temperature and in propellants (h) through (j) for 30 minutes at normal room temperature:-

- (a) Ethyl alcohol, ACS grade, 99.5% pure.
- (b) Isopropyl alcohol, best commercial grade, 99% pure.
- (c) Acetone, electronic grade.
- (d) Xylene, electronic grade.
- (e) Propellant, hydrazine, Military Specification MIL-P-26536.
- (f) Propellant, nitrogen tetroxide, Military Specification MIL-P-26539.
- (g) Propellant, dimethylhydrazine (UDMH), ARIANE grade.

On removal from the liquids, the specimens shall remain for 1 hour in free air at room temperature. Subsequently, 25mm of insulation shall be removed from each end of the specimen. The specimen shall then be subjected to the wrap test (see Para. 9.13) and voltage test (see Para. 9.7). During the immersion tests, the bend of the specimen shall not be less than 6 times its specified maximum diameter.

9.22 SURFACE RESISTANCE (FED-STD-228-6041)

Specimens shall consist of 15cm lengths of finished wire or core provided with 2 4.2mm ring-type foil electrodes or, for small wires, several turns of fine tin-coated copper wire, spaced 25mm apart between nearest edges nearest the centre of the specimen length, wrapped snugly around the axis of the specimen and bound with take-off leads for electrical testing of the surface between the electrodes.

After conditioning, the specimens prepared as above for 96 hours at a relative humidity of 95 ± 5 % and at a temperature of $+22 \pm 3$ °C, the resistance between the electrodes shall be measured with a d.c. potential of 200V to 500V while the specimens are still in the conditioning chamber and after 1 minute of electrification.

The surface resistance shall be computed by multiplying the measured resistance value by the measured (overall) diameter of the specimen in mm. Following the initial measurement of surface resistance, a 2 500Vrms, 50 cycle, potential shall be applied between the electrodes for a period of 1 minute.



There shall be no evidence of distress such as arcing, smoking or burning, flash-over or dielectric failures. After a discharge of 15 to 20 minutes following the potential test, the surface resistance shall be measured and computed. Both values of computed surface resistance shall be greater than specified in the Detail Specification.

9.23 ABRASION RESISTANCE

1 50cm long sample shall be used for this test.

The equipment shall be in accordance with the details given in Figure II and so designed that the surface of the insulation is worn in parallel with the wire axis over a length of not less than 10mm at a rate of 50 to 60 cycles per minute.

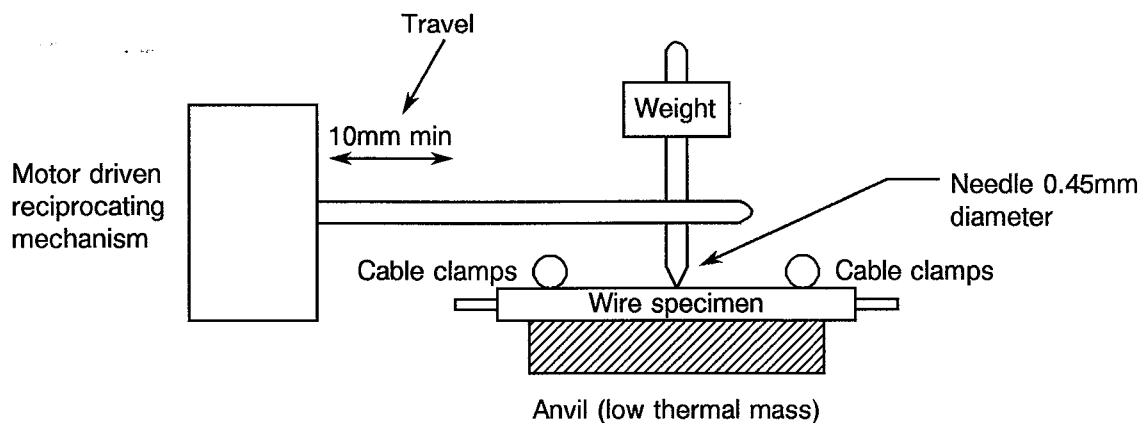
The test system shall be fitted with a counter and an automatic cut-out to detect contact between the abrading needle and conductor. The weight applied to the needle shall be as given in the Detail Specification.

The needle used shall have a diameter of 0.45mm (size No. 10).

4 tests shall be made on each specimen with the specimen being moved forward 100mm and rotated through 90° in 1 direction between tests.

The scrape abrasion resistance is defined as the number of complete cycles for the needle to wear through the complete conductor covering and stop the machine. Each total number of cycles recorded shall be not less than 100.

FIGURE II - ABRASION RESISTANCE TEST RIG



A cycle is defined as being equal to the needle movement to its maximum travel followed by return to its original position.

9.24 RADIATION RESISTANCE

A specimen of 1.0m in length shall be subjected to a radiation dosage of 1.0Megarad. The radiation rate shall not exceed 0.1Megarad per minute.

After having been irradiated, the specimen shall not show any cracks and shall withstand the voltage test (see Para. 9.14).

**9.25 LONG-TERM AGEING TEST**

This test shall be performed on 10, 60cm long, samples in the same manner as the “accelerated ageing test” (see Para. 9.12) except for the following conditions:



- The duration shall be at least 2000 hours.
- The temperature shall be the maximum storage temperature specified in Table 1(b) of the Detail Specification.

9.26 WRAPPING ABILITY

10 samples shall be wrapped on terminal posts following the procedure described in ESAPSS-01-730.

The stripping force test shall be performed on 5 samples and shall meet the requirements of ESAPSS-01-730, Para. 6.3.

The unwrapping test shall be performed on 5 samples and shall meet the requirements of ESAPSS-01-730, Para. 6.4.

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10. DATA DOCUMENTATION

10.1 GENERAL

For the qualification approval records and with each component delivery, a data documentation package is required. Depending on the testing level and lot acceptance level specified for the component, this package shall be compiled from:-

- (a) Cover sheet (or sheets).
- (b) List of equipment (testing and measuring).
- (c) List of test references.
- (d) Special in-process control test data.
- (e) Final production test data (Chart II) (but see Para 10.6).
- (f) Qualification test data (Chart IV).
- (g) Lot acceptance test data (Chart V) (when applicable).
- (h) Failed component list (see Para. 8.4) and failure analysis report (see Para 8.4).
- (i) Certificate of Conformity.

Items (a) to (i) inclusive shall be grouped, preferably as subpackages and, for identification purposes, each page shall include the following information:

- ESA/SCC Component number.
- Manufacturer's name.
- Lot identification.
- Date of establishment of the document.
- Page number.

10.1.1 Qualification Approval

In the case of qualification approval, the items listed in Para 10.1 (a) to (i) less item (g) are required.

10.1.2 Testing Level 'B'

10.1.2.1 Qualified Components

For deliveries of qualified components, the following documentation shall be supplied:-

- (a) Cover sheet (if all of the information is not included on the Certificate of Conformity).
- (b) Certificate of Conformity (including range of delivered spool numbers).
- (c) Attributes record of measurements, tests and inspections performed in Chart II and Chart V (where applicable).
- (d) Failed components list.



10.1.2.2 Unqualified Components

For deliveries of unqualified components, the documentation to be supplied shall be in accordance with Para. 10.1.2.1 plus the following:-

- (a) Special in-process control data (where applicable).
- (b) Failure analysis report on failed components.

10.1.3 Testing Level 'C'

Not applicable.

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10.1.4 Data Retention/Data Access

If not delivered, all data shall be retained by the Manufacturer for a minimum of 5 years during which time it shall be available to the Qualifying Space Agency and the Orderer, if requested, for review. The Manufacturer shall deliver variables Data/Reports to the Orderer if required by the Purchase Order.

10.2 COVER SHEET(S)

The cover sheet(s) of the data documentation package shall include as a minimum:-

- (a) Reference to the Detail Specification, including issue and date.
- (b) Reference to the applicable ESA/SCC Generic Specification, including issue and date.
- (c) Component type and number.
- (d) Lot identification.
- (e) Range of delivered spool numbers.
- (f) Number of purchase order.
- (g) Information relative to any additions to this specification and/or the Detail Specification.
- (h) Manufacturer's name and address.
- (j) Location of the manufacturing plant.
- (k) Signature on behalf of Manufacturer.
- (l) Total number of pages of the data package.

10.3 LIST OF EQUIPMENT USED

A list of equipment used for tests and measurements shall be prepared, if not in accordance with the data given in the Process Identification Document (P.I.D.). Where applicable, this list shall contain inventory number, Manufacturer's type number, serial number, etc. This list shall indicate for which tests such equipment was used.

10.4 LIST OF TEST REFERENCES

This list shall include all Manufacturer's references or codes which are necessary to correlate the test data provided with the applicable tests specified in the tables of the Detail Specification.

10.5 SPECIAL IN-PROCESS CONTROL DATA

As specified in the Detail Specification.

10.6 FINAL PRODUCTION TEST DATA (CHART II)

A test result summary shall be compiled showing the total number of components submitted to, and the total number rejected after, each test, measurement and inspection of Chart II.

The final production test data shall form an integral part of the data documentation package, but it is not a mandatory requirement that it be delivered with the qualification lot or delivery lot. However, the data package to be delivered shall contain the information as detailed in Para. 10.1.2 or at least shall contain a list of final production tests actually performed and a certification that the data is available for review.

10.7 BURN-IN AND ELECTRICAL MEASUREMENT DATA (CHART III)

Not applicable.

10.8 QUALIFICATION TEST DATA (CHART IV)

All data shall be referenced to the relevant spool numbers. Detailed records shall be provided of the components submitted to each test in each of the subgroups and of those rejected. Detailed data shall be provided of all electrical measurements made in accordance with Table 2 of the Detail Specification, as and where applicable.

**10.9 LOT ACCEPTANCE TEST DATA (CHART V)****10.9.1 Testing Level 'B'**

All data shall be referenced to the relevant serial numbers. Detailed records shall be provided of the components submitted to each test in each of the subgroups (as relevant to the lot acceptance level) and of those rejected.

Detailed data shall be provided of all electrical measurements made in accordance with Table 2 of the Detail Specification, as and where applicable.

10.9.2 Testing Level 'C'

Not applicable.

10.10 FAILED COMPONENTS LIST AND FAILURE ANALYSIS REPORT

The failed components list and failure analysis report shall provide full details of:-

- (a) The reference number and description of the test or measurement performed as defined in this specification and/or the Detail Specification.
- (b) The spool number (if applicable) of the failed component.
- (c) The failed parameter and the failure mode of the component.
- (d) Detailed failure analysis, if requested.

10.11 CERTIFICATE OF CONFORMITY

A Certificate of Conformity shall be established as defined in ESA/SCC Basic Specification No. 20100.

11. DELIVERY

For qualification approval, the disposition of the qualification test lot and its related documentation shall be as specified in ESA/SCC Basic Specification No. 20100 and the relevant paragraphs of Section 10 of this specification.

For procurement, for each order, the items forming the delivery are:-

- (a) The delivery lot.
- (b) The components used for lot acceptance testing, (when applicable), but not forming part of the delivery lot (see Para's 8.2.4(a) and 8.2.5(a)).
- (c) The relevant documentation in accordance with the requirements of Section 10 of this specification.

In the case of a component for which a valid qualification approval is in force, all data of all components submitted to LA1 and LA2 testing shall also be copied, when requested, to the relevant Qualifying Space Agency.

**12. PACKAGING AND DESPATCH**

The packaging and despatch of components to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 20600 and the following rules:-

- (a) All finished wires shall be packaged on spools.
- (b) One spool shall only receive finished wire from a unique lot.
- (c) All finished wire ends shall be accessible over a length of at least 10cm out from the spool.
- (d) No more than 3 lengths of wire shall be wound on the same spool; each wire end shall be marked.
- (e) No spool shall receive more than 500 metres of finished wire; no unit length shall be less than 30 metres.
- (f) Spool hubs shall be cylindrical and have a diameter exceeding 70 times the maximum external wire diameter for single wires, or 30 times the maximum external diameter for twisted wires.
- (g) For storage, the wire spools shall be heat-sealed into polyethylene bags. The bags shall be sufficiently large to enable resealing at least twice. The humidity indicators shall be placed such that they can be inspected easily without breaking the moisture seal. Polyvinylchloride shall not be used as packaging or packing material.

Desiccant or dry nitrogen shall be used in the package. An easy means for indicating that the humidity is below 50% RH shall be provided, capable of being read without opening the package.

- (h) For shipment, the bags specified under (g) shall be placed in another polyethelene bag which shall be sealed to prevent damage to the primary package. This second bag may be removed for further storage.